


<b>Search Notes</b>  	<b>Application/Control No.</b>  10595694	<b>Applicant(s)/Patent Under Reexamination</b>  YOUNG ET AL.
	<b>Examiner</b>  JON CHANG	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
IEEE Xplore Search (see search history printout)	05/19/09	JC
EAST (see search history printout)	05/19/09	JC
Inventor Name Search	05/22/09	JC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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